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20-BIT FET BUS SWITCH

2.5-V/3.3-V LOW-VOLTAGE BUS SWITCH WITH 5-V-TOLERANT LEVEL SHIFTER

Check for Samples: SN74CB3T16210-Q1

FEATURES

- **Qualified for Automotive Applications**
- Member of the Texas Instruments Widebus™ Family
- Output Voltage Translation Tracks V_{CC}
- Supports Mixed-Mode Signal Operation on All Data I/O Ports
 - 5-V Input Down to 3.3-V Output Level Shift With 3.3-V V_{CC}
 - 5-V/3.3-V Input Down to 2.5-V Output Level Shift With 2.5-V V_{CC}
- 5-V-Tolerant I/Os With Device Powered Up or **Powered Down**
- **Bidirectional Data Flow With Near-Zero Propagation Delay**
- Low ON-State Resistance (r_{on}) Characteristics ٠ $(r_{on} = 5 \Omega Typ)$
- Low Input/Output Capacitance Minimizes Loading ($C_{io(OFF)} = 5 \text{ pF Typ}$)
- **Data and Control Inputs Provide Undershoot** Clamp Diodes
- Low Power Consumption $(I_{CC} = 40 \ \mu A Max)$
- V_{CC} Operating Range From 2.3 V to 3.6 V
- Data I/Os Support 0- to 5-V Signaling Levels (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)
- Control Inputs Can Be Driven by TTL or 5-V/3.3-V CMOS Outputs
- Ioff Supports Partial-Power-Down Mode Operation

- Supports Digital Applications: Level Translation, PCI Interface, USB Interface, Memory Interleaving, and Bus Isolation
- Ideal for Low-Power Portable Equipment

DGG PACKAGE (TOP VIEW)							
		J					
NC [48	<u> </u>				
1A1 [2	47]20E				
1A2 [3	46	[]1B1				
1A3 [4	45	U1B2				
1A4 [5	44] 1B3				
1A5 [6	43]1B4				
1A6 [7	42]1B5				
GND [8	41] GND				
1A7 [9	40]1B6				
1A8 [10	39] 1B7				
1A9 [11	38	1B8				
1A10 [12	37] 1B9				
2A1 [13	36]1B10				
2A2 [14	35	2B1				
V _{CC} [15	34]2B2				
2A3 [16	33]2B3				
GND [17	32] GND				
2A4 [18	31]2B4				
2A5 [19	30	2B5				
2A6 [20	29	2B6				
2A7 [21	28	287				
2A8 [22	27]2B8				
2A9 [23	26]2B9				
2A10 [24	25]2B10				

NC - No internal connection

DESCRIPTION/ORDERING INFORMATION

The SN74CB3T16210-Q1 is a high-speed TTL-compatible FET bus switch with low ON-state resistance (r_{on}), allowing for minimal propagation delay. The device fully supports mixed-mode signal operation on all data I/O ports by providing voltage translation that tracks V_{CC}. The SN74CB3T16210-Q1 supports systems using 5-V TTL, 3.3-V LVTTL, and 2.5-V CMOS switching standards, as well as user-defined switching levels (see Figure 1).



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

DESCRIPTION/ORDERING INFORMATION (CONTINUED)

The SN74CB3T16210-Q1 is organized as two 10-bit bus switches with separate <u>ouput-enable</u> $(1\overline{OE}, 2\overline{OE})$ inputs. It can be used as two 10-bit bus switches or as one 20-bit bus switch. When \overline{OE} is low, the associated 10-bit <u>bus</u> switch is ON, and the A port is connected to the B port, allowing bidirectional data flow between ports. When \overline{OE} is high, the associated 10-bit bus switch is OFF, and a high-impedance state exists between the A and B ports.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

ORDERING INFORMATION								
T _A	PACKAGE	(1)	ORDERABLE PART NUMBER	TOP-SIDE MARKING				
–40°C to 125°C	TSSOP – DGG	Reel of 2000	CCB3T16210QDGGRQ1	CB3T16210Q				

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

INPUT **INPUT/OUTPUT** FUNCTION OE Α В L A port = B port н Ζ Disconnect Vcc 5.5 V Vcc OUT JOJ V₅ IN ≈V_{CC} - 1 V V_{CC} - 1 V CB3T 0 V 0 V **Input Voltages Output Voltages**

FUNCTION TABLE (EACH 10-BIT BUS SWITCH)

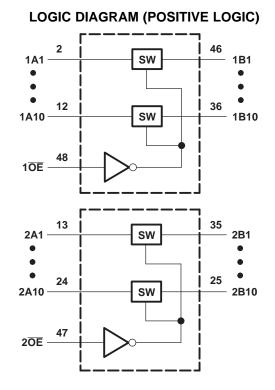
If the input high voltage (V_{IH}) level is greater than or equal to V_{CC} - 1 V, and less than or equal to 5.5 V, the output high voltage (V_{OH}) level will be equal to approximately the V_{CC} voltage level.

Figure 1. Typical DC Voltage Translation Characteristics

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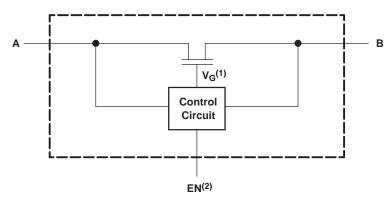


ISTRUMENTS

EXAS

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SIMPLIFIED SCHEMATIC, EACH FET SWITCH (SW)



(1) Gate voltage (V_G) is equal to approximately $V_{CC} + V_T$ when the switch is ON and $V_I > V_{CC} + V_T$. (2) EN is the internal enable signal applied to the switch.

Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
V _{IN}	Control input voltage range ^{(2) (3)}		-0.5	7	V
V _{I/O}	Switch I/O voltage range ^{(2) (3) (4)}		-0.5	7	V
I _{IK}	Control input clamp current	V _{IN} < 0		-50	mA
I _{I/OK}	I/O port clamp current	V _{I/O} < 0		-50	mA
I _{IO}	ON-state switch current ⁽⁵⁾			±128	mA
	Continuous current through V_{CC} or GND			±100	mA
θ_{JA}	Package thermal impedance ⁽⁶⁾	DGG package		70	°C/W
T _{stg}	Storage temperature range		-65	150	°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings (1) only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2)All voltages are with respect to ground unless otherwise specified.

The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed. (3)

(4) V_I and V_O are used to denote specific conditions for $V_{I/O}$.

(5)

 I_i and I_O are used to denote specific conditions for I_{IO} . The package thermal impedance is calculated in accordance with JESD 51-7. (6)

Recommended Operating Conditions⁽¹⁾

		MIN	MAX	UNIT
Supply voltage		2.3	3.6	V
$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		1.7	5.5	V
High-level control input voltage	V_{CC} = 2.7 V to 3.6 V	2	5.5	V
$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0	0.7	V
Low-level control input voltage $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$			0.8	v
Data input/output voltage		0	5.5	V
Operating free-air temperature		-40	125	°C
	High-level control input voltage Low-level control input voltage Data input/output voltage	High-level control input voltage $V_{CC} = 2.3 \vee to 2.7 \vee$ Low-level control input voltage $V_{CC} = 2.7 \vee to 3.6 \vee$ Data input/output voltage $V_{CC} = 2.7 \vee to 3.6 \vee$		

(1) All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

			T _A = -40°C TO 125°C					
PA	RAMETER	TEST CONDITIO	NS	MIN	TYP ⁽²⁾	MAX	UNIT	
V _{IK}		$V_{CC} = 3 V, I_{I} = -18 mA$				-1.2	V	
V _{OH}		See Figure 3 and Figure 4						
I _{IN}	Control inputs	V_{CC} = 3.6 V, V_{IN} = 3.6 V to 5.5 V or GND				±10	μA	
	$V_{CC} = 3.6 V,$		$V_{I} = V_{CC} - 0.7 \text{ V to } 5.5 \text{ V}$			±20		
li 5		Switch ON,	$V_{I} = 0.7$ V to $V_{CC} - 0.7$ V			-40	μA	
		$V_{IN} = V_{CC} \text{ or } GND$	$V_{I} = 0$ to 0.7 V			±5		
I_{OZ} ⁽³⁾		$V_{CC} = 3.6 \text{ V}, V_{O} = 0 \text{ to } 5.5 \text{ V}, V_{I} = 0$, Switch O	FF, V _{IN} = V _{CC} or GND			±10	μA	
I _{off}		$V_{CC} = 0, V_{O} = 0$ to 5.5 V, $V_{I} = 0$,				10	μA	
		$V_{CC} = 3.6 \text{ V}, \text{ I}_{I/O} = 0,$	$V_I = V_{CC}$ or GND		40		μA	
I _{CC}	Switch ON or OFF , $V_{IN} = V_{CC}$ or GND		V _I = 5.5 V			40	μΑ	
ΔI_{CC} ⁽⁴⁾	Control inputs	V_{CC} = 3 V to 3.6 V, One input at V_{CC} – 0.6 V	$_{\rm C}$ = 3 V to 3.6 V, One input at V_{CC} – 0.6 V, Other inputs at V_{CC} or GND				μA	
C _{in}	Control inputs	V_{CC} = 3.3 V, V_{IN} = V_{CC} or GND			4		pF	
Cio(OFF)		V_{CC} = 3.3 V, $V_{I/O}$ = 5.5 V, 3.3 V, or GND, Swi	tch OFF, V _{IN} = V _{CC} or GND		5		pF	
		$V_{CC} = 3.3 \text{ V}$, Switch ON, $V_{IN} = V_{CC}$ or GND	$V_{I/O} = 5.5 \text{ V or } 3.3 \text{ V}$		5		~ Г	
C _{io(ON)}		$v_{CC} = 3.3 \text{ v}, \text{ Switch ON}, v_{IN} = v_{CC} \text{ of GND}$	$V_{I/O} = GND$		13		pF	
			I _O = 24 mA		5	11.5		
, (5)		V_{CC} = 2.3 V, TYP at V_{CC} = 2.5 V, V_I = 0	l _O = 16 mA		5	11.5	Ω	
r _{on} ⁽⁵⁾		$V_{CC} = 3 V, V_1 = 0$	I _O = 24 mA		5	10.5		
		$v_{CC} = 5 v, v_1 = 0$	I _O = 16 mA		5	10.5		

Electrical Characteristics⁽¹⁾

(1)

(2)

(3)

(4)

 V_{IN} and I_{IN} refer to control inputs. V_I , V_O , I_I , and I_O refer to data pins. All typical values are at $V_{CC} = 3.3$ V (unless otherwise noted), $T_A = 25^{\circ}$ C. For I/O ports, the parameter I_{OZ} includes the input leakage current. This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND. Measured by the voltage drop between A and B terminals at the indicated current through the switch. ON-state resistance is determined (5) by the lower of the voltages of the two (A or B) terminals.

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Switching Characteristics

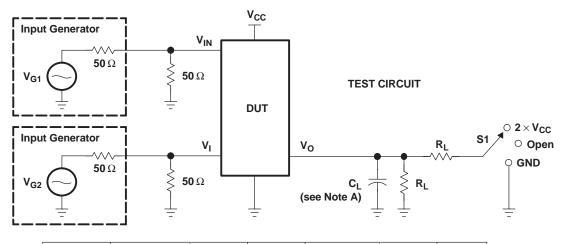
for V_{CC} = 2.5 V \pm 0.2 V (see Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 2 ± 0.2	2.5 V 2 V	V _{CC} = 3 ± 0.3	UNIT	
		(001F01)	MIN	MAX	MIN	MAX	
t _{en}	OE	A or B	1	14	1	12	ns
t _{dis}	OE	A or B	1	9.5	1	10.5	ns

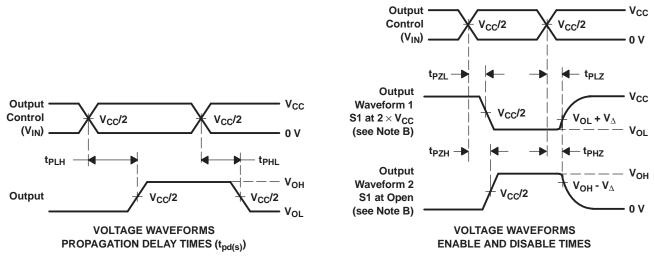


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PARAMETER MEASUREMENT INFORMATION



TEST	V _{CC}	S1	RL	VI	CL	V_{Δ}
t _{pd(s)}	$\textbf{2.5 V} \pm \textbf{0.2 V}$	Open	500 Ω	3.6 V or GND	30 pF	
-pd(3)	3.3 V \pm 0.3 V	Open	500 Ω	5.5 V or GND	50 pF	
t _{PLZ} /t _{PZL}	$\textbf{2.5 V} \pm \textbf{0.2 V}$	$2 \times V_{CC}$	500 Ω	GND	30 pF	0.15 V
PLZYPZL	3.3 V \pm 0.3 V	$2 \times V_{CC}$	500 Ω	GND	50 pF	0.3 V
t _{PHZ} /t _{PZH}	$2.5 \text{ V} \pm 0.2 \text{ V}$	Open	500 Ω	3.6 V	30 pF	0.15 V
'PHZ''PZH	3.3 V \pm 0.3 V	Open	500 Ω	5.5 V	50 pF	0.3 V



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z₀ = 50 Ω , t_r \leq 2.5 ns, t_f \leq 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as $t_{\text{dis}}.$
- F. $t_{PZL} \mbox{ and } t_{PZH} \mbox{ are the same as } t_{en}.$
- G. t_{PLH} and t_{PHL} are the same as t_{pd(s)}. The tpd propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
- H. All parameters and waveforms are not applicable to all devices.

Figure 2. Test Circuit and Voltage Waveforms

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TYPICAL CHARACTERISTICS

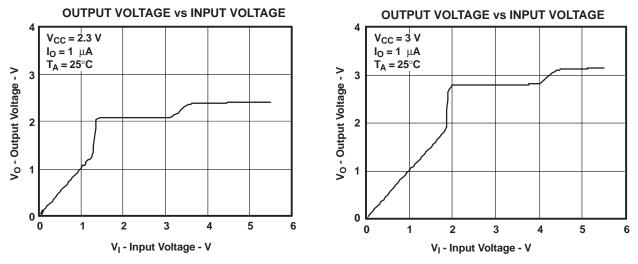


Figure 3. Data Output Voltage vs Data Input Voltage



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TYPICAL CHARACTERISTICS

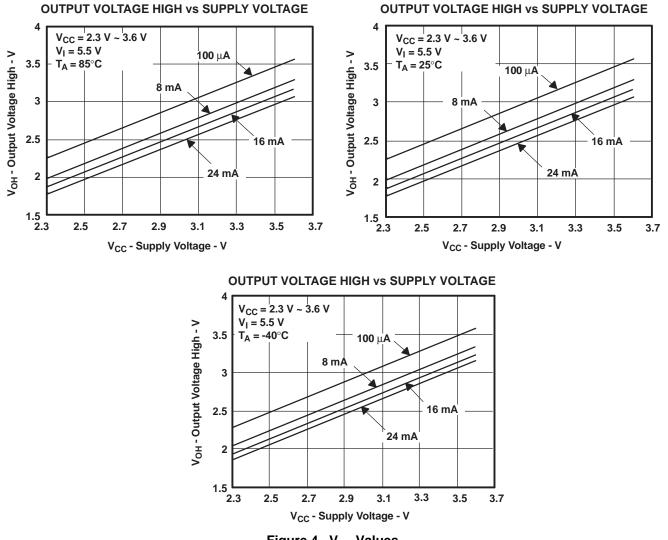


Figure 4. V_{OH} Values



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
CCB3T16210QDGGRQ1	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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OTHER QUALIFIED VERSIONS OF SN74CB3T16210-Q1 :

• Catalog: SN74CB3T16210

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

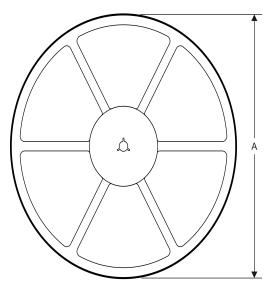
PACKAGE MATERIALS INFORMATION

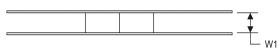
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TAPE AND REEL INFORMATION

REEL DIMENSIONS

Texas Instruments





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CCB3T16210QDGGRQ1	TSSOP	DGG	48	2000	330.0	24.4	8.6	15.8	1.8	12.0	24.0	Q1

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PACKAGE MATERIALS INFORMATION

14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CCB3T16210QDGGRQ1	TSSOP	DGG	48	2000	367.0	367.0	45.0

MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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